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In the Claims:

- 1. (currently amended) A near-hermetic microwave semiconductor device comprising:
 - a substrate;
 - a Monolithic Microwave Integrated Circuit (MMIC) disposed on said substrate;
 - a sealant disposed on said MMIC; and
- a Backside Interconnect which connects connecting said substrate to said sealant-coated MMIC, includes including plated-through vias disposed on in said MMIC extending between opposite faces of said MMIC, and ties tving to terminals on said substrate.
- 2. (original) The microwave semiconductor device according to claim 1, wherein said substrate is a PWB suitable for ultrahigh frequency applications.
- 3. (original) The microwave semiconductor device according to claim 2, wherein said ultrahigh frequency applications include Phased Array Antenna (PAA) systems.
- 4. (original) The microwave semiconductor device according to claim 2, wherein said substrate is formed of one of a liquid crystal polymer (LCP) and a ceramic.
- 5. (currently amended) A near-hermetic microwave semiconductor device comprising:
 - a substrate;
 - a Monolithic Microwave Integrated Circuit (MMIC) disposed on said substrate;
 - a sealant disposed on said MMIC comprising a layer of silicon carbide; and
- a Backside Interconnect which connects connecting said substrate to said sealant-coated MMIC, includes including plated-through vias disposed on in said MMIC extending between opposite faces of said MMIC, and ties tying to terminals on said substrate.
- 6. (currently amended) A near-hermetic microwave semiconductor device comprising:

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- a substrate;
- a Monolithic Microwave Integrated Circuit (MMIC) disposed on said substrate;
- a sealant disposed on said MMIC; and
- a Backside Interconnect extending between opposite faces of said MMIC and connecting said substrate to said sealant-coated MMIC,

wherein said sealant is disposed over benzocyclobutene (BCB) as an interlayer dielectric.

- 7. (original) The microwave semiconductor device according to claim 1, wherein said MMIC is a GaAs MMIC.
- 8. (previously presented) The microwave semiconductor device according to claim 5, wherein the device is substantially free of bond wires and solder balls.
- 9. (previously presented) The microwave semiconductor device according to claim 1, further comprising a plurality of rest vias connecting the MMIC to a bottom ground plane of the substrate.
- 10. (previously presented) The microwave semiconductor device according to claim 1, further comprising a solder attachment along a periphery of said MMIC, to near-hermetically seal said MMIC to said substrate.
- 11. (original) The microwave semiconductor device according to claim 10, wherein the said solder attachment is formed using AuSn solder.
- 12. (original) The microwave semiconductor device according to claim 1, further comprising a conformal coating disposed on said sealant.
- 13. (previously presented) The microwave semiconductor device according to claim 12, further comprising a cover disposed over said conformal-coated MMIC in a non-contacting manner.

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- 14. (original) The microwave semiconductor device according to claim 1, further comprising a cover disposed on said MMIC.
 - 15. (currently amended) A near-hermetic device comprising:
 - a substrate:
 - an electronics package disposed on said substrate;
 - a sealant disposed on said electronics package;
- a Backside Interconnect which connects extending between opposite faces of the electronics package and connecting said substrate to said sealant-coated electronics package; and
- an interlayer dielectric disposed between said sealant and said electronics package.
- 18. (original) The near-hermetic device according to claim 15, wherein said electronics package is solder-attached to seal said electronics package to said substrate.
 - 17. (currently amended) A near-hermetic microwave semiconductor device, comprising:
 - a substrate;
 - a Monolithic Microwave Integrated Circuit (MMIC) disposed on said substrate;
 - a sealant disposed on said MMIC;
 - a Backside Interconnect which connects extending between opposite faces of said MMIC and connecting said substrate to said sealant-coated MMIC;
 - a conformal coating disposed on said sealant; and
 - a cover disposed on said device without directly contacting said coating.
 - 18. (previously presented) The near-hermetic microwave semiconductor device according to claim 17, wherein the device is substantially free of solder balls and bond pads and said coating is a low dielectric having a dielectric constant suitable for operating at an operational frequency between about 2 GHz and about 10 GHz.

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19-26. (canceled)

- 27. (previously presented) The microwave semiconductor device according to claim 6, wherein said substrate is a PWB suitable for ultrahigh frequency applications.
- 28. (previously presented) The microwave semiconductor device according to claim 27, wherein said ultrahigh frequency applications include Phased Array Antenna (PAA) systems.
- 29. (previously presented) The microwave semiconductor device according to claim 27, wherein said substrate is formed of one of a liquid crystal polymer (LCP) and a ceramic.
- 30. (previously presented) The microwave semiconductor device according to claim 6, wherein said sealant comprises a layer of silicon carbide.
- 31. (previously presented) The microwave semiconductor device according to claim 6, wherein said MMIC is a GaAs MMIC.
- 32. (previously presented) The microwave semiconductor device according to claim 6, further comprising a solder attachment along a periphery of said MMIC, to seal said MMIC to said substrate.
- 33. (previously presented) The microwave semiconductor device according to claim 6, further comprising a conformal coating disposed on said sealant.
- 34. (previously presented) The microwave semiconductor device according to claim 6, further comprising a cover disposed on said MMIC.